

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Tsuneo Abe

Serial No.: 10/758,527

Filing Date: January 16, 2004

For: SEMICONDUCTOR DEVICE HAVING A TEST CIRCUIT FOR TESTING
AN OUTPUT CIRCUIT

Honorable Commissioner of Patents
Alexandria, Virginia 22313-1450



Group Art Unit: Not Yet Assigned

Examiner: Unknown

INFORMATION DISCLOSURE STATEMENT

Sir:

Under the provisions of 37 CFR §1.97 through §1.99 and pursuant to applicant's duty of disclosure under 37 CFR §1.56, applicant respectfully brings the following documents listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. Copies of the listed documents are provided herewith for the convenience of the Examiner. In compliance with the concise explanation requirement under 37 CFR §1.98(a)(3), the relevance of these documents is discussed on pages 1, 3 and 4 of the subject application. Further, English-language Abstracts are attached to the references.

This citation does not constitute an admission that the references are relevant or material to the claims. They are only cited as constituting related art of which the applicant is aware.

It is respectfully requested that the listed references be considered by the Examiner and formally made of record in this application.

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 50-0481.

Respectfully submitted,

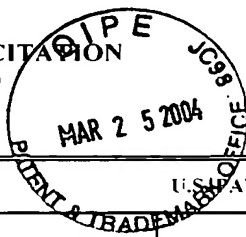
A handwritten signature in black ink, appearing to read "Sean M. McGinn".

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INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)

03288-1/2003-011440

Application Number

10/758,527

Applicant(s)

Tsuneo Abe

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		11-30649	02/02/1999	Japan			ABS	
		2000-214225	08/04/2000	Japan			ABS	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.